



National Institute of Standards & Technology

Certificate of Analysis Standard Reference Material 3150

Silicon

This Standard Reference Material (SRM) is intended for use in atomic absorption spectrometry, optical emission (plasma) spectrometry, spectrophotometry, or any other analytical technique that requires aqueous standard solutions for calibrating instruments. SRM 3150 is a single element solution prepared gravimetrically to contain 10.00 mg/mL of silicon in water. The certified value is based on a gravimetric procedure, i.e., weight per volume composition of the high-purity salt dissolved in NIST high-purity reagents.

Metal	Concentration (mg/mL)	Source Purity, %	Acid Conc. (V/V) Approximate
Si	10.00 ± 0.03	Na ₂ SiO ₃ • 9H ₂ O(99.99)*	Water

* This high-purity material was analyzed by optical emission spectrometry and atomic absorption spectrometry and found to contain less than 50 µg/g total impurities.

Procedures and Storage for Use

Stability

This certificate is valid for one year from the shipping date provided the SRM solution is kept tightly capped and stored under normal laboratory conditions. NIST will monitor the stability representative solutions from the SRM lot and if any changes occur that invalidate this certification, NIST will notify purchasers.

Preparation of Working Standard Solutions:

The SRM solution should be brought to 22 ± 1 °C before use. All glass or plastic surfaces coming into contact with the SRM must have been previously cleaned. A working standard solution can be prepared from the SRM solution by serial dilution. Dilutions should be made with certified volumetric class A flasks and 5 or 10 mL class A pipets. All volumetric transfers of solutions should be performed using a proven analytical technique. Each dilution should be acidified with an appropriate high-purity acid and diluted to calibrated volume using high-purity water. The stability of the working standard solution will depend on the final acid concentration; therefore, care should be exercised to insure that the final acid concentration of the dilution closely approximates that of the SRM. To achieve the highest accuracy, the analyst should prepare daily working solutions from 100 µg/mL dilutions of the original SRM solution.

Notice to Users:

The same acid mixture as listed on this SRM certificate should be used in making appropriate dilutions and working standards. For some instrumental techniques, small differences in acid type and concentration of the SRM and sample may lead to erroneous results.

Gaithersburg, MD 20899
August 11, 1989
(Revision of certificate dated 12-22-86)

Stanley D. Rasberry, Chief
Office of Standard Reference Materials

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SRM 3150 was prepared by T.C. Rains of the NIST Inorganic Analytical Research Division. Gravimetry and emission spectrometry analyses were made by T.A. Butler, T.C. Rains, and J.A. Norris.

The technical and support aspects involved in the preparation, certification, and issuance of this Standard Reference Material were coordinated through the Office of Standard Reference Materials by T.E. Gills.